



Lifetime of MCP-PMTs

Albert Lehmann,
Merlin Böhm, Alexander Britting, Wolfgang Eyrich,
Markus Pfaffinger, Fred Uhlig
(Universität Erlangen-Nürnberg)

- Motivation
- Approaches to increase lifetime
- Results of aging tests
- Outlook and summary





FAIR and HESR/PANDA at GSI

Facility for Antiproton and Ion Research

protons (up to 30 GeV/c)

antiprotons (up to 15 GeV/c)

PANDA

\bar{p} -Target

HESR

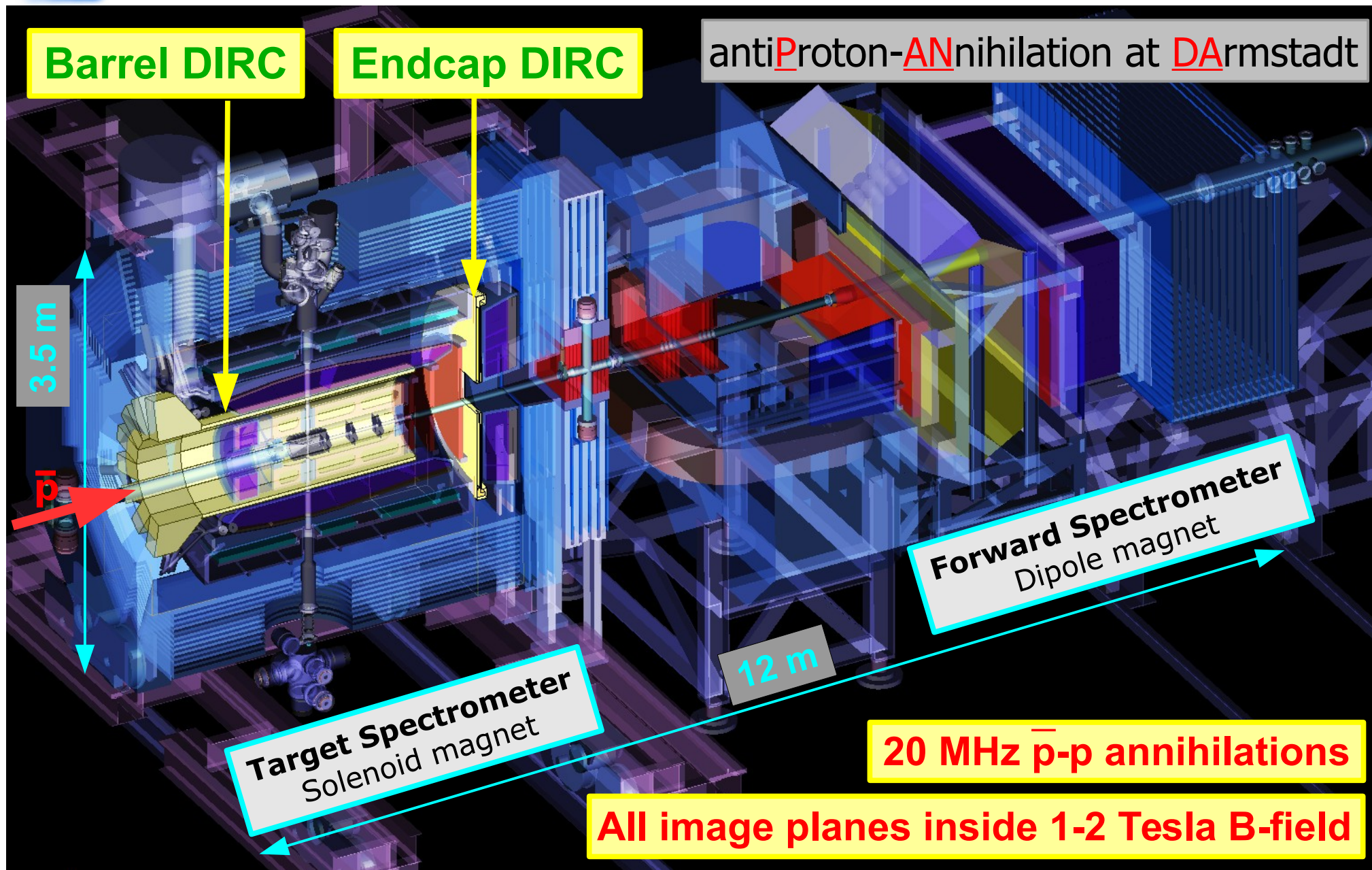
CR/RESR

HESR and PANDA

- stored antiprotons: $\sim 10^{11}$
- momentum resolution: $\sim 10^{-5}$
- luminosity: $\sim 2 \cdot 10^{32} \text{ cm}^{-2} \text{ s}^{-1}$



PANDA Detector at FAIR





Challenges to Photon Sensors

- Good geometrical resolution over a large surface
 - **multi-pixel sensors** with $\sim 5 \times 5$ mm² anodes (0.5x16 mm² for Disk DIRC)
- Single photon detection inside B-field
 - **high gain** ($> 5 \times 10^5$) in up to 2 Tesla
- Time resolution for ToP and/or dispersion correction
 - **very good time resolution** of < 100 ps for single photons
- Few photons per track
 - **high detection efficiency** $\eta = QE * CE * GE$
[QE = quantum efficiency; CE = collection efficiency; GE = geometrical efficiency]
 - **low dark count rate**
- Photon rates in the MHz regime
 - **high rate capability** with rates up to MHz/cm²
 - **long lifetime** with integrated anode charge of 0.5 to 2 C/cm²/y



Rate Estimates for PANDA

- **rate capability and lifetime are the most critical issues** for the application of MCP-PMTs in any high-rate experiment
- expected rates and anode charges of the PANDA DIRCs:

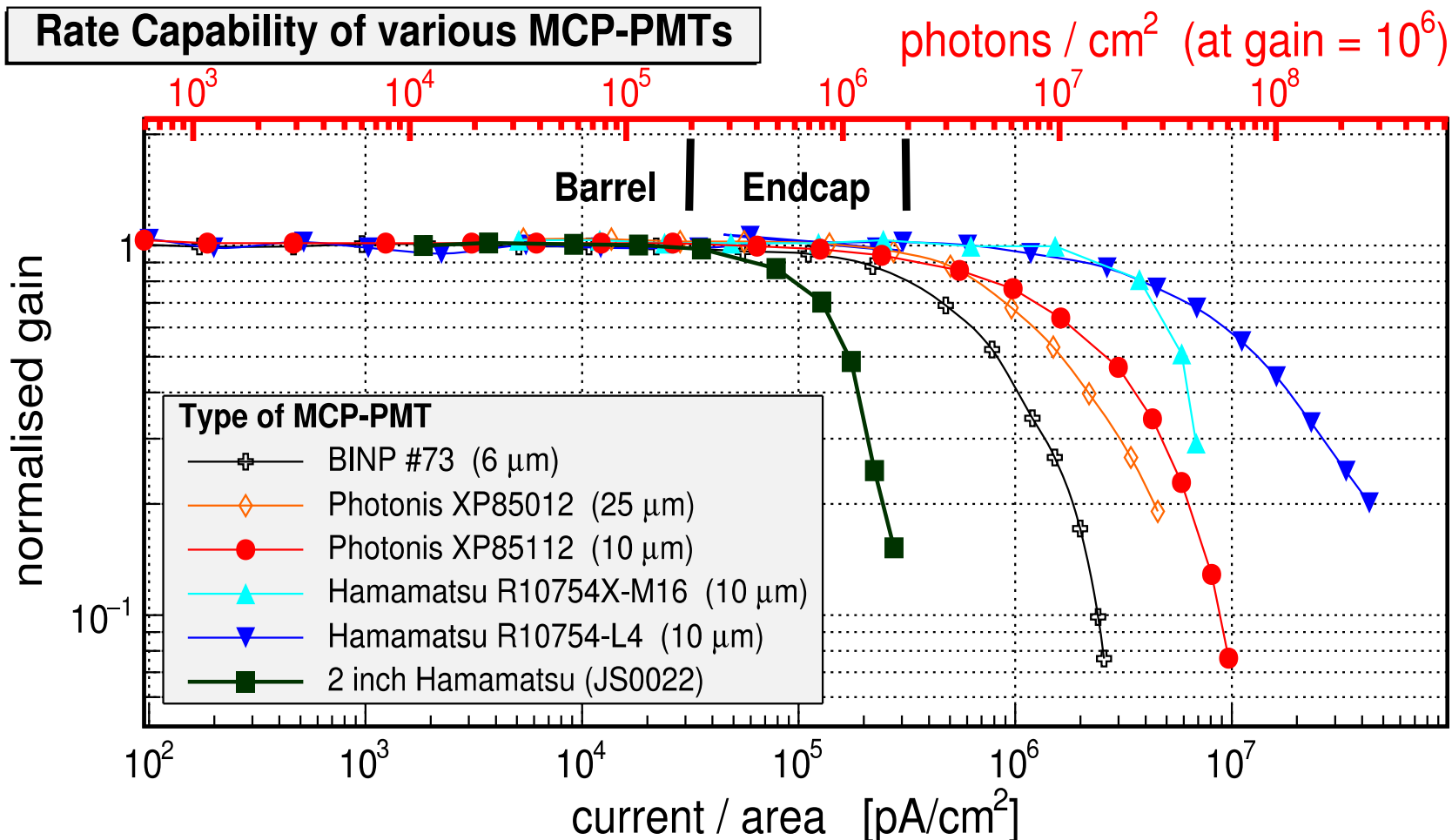
	total rate	anode rate (after Q.E.)	integrated anode charge / year	integrated anode charge / 10 years
	[MHz/cm ²]	[MHz/cm ²]	[C/cm ² /year] at 10 ⁶ gain (at 100% dc)	[C/cm ²] at 10 ⁶ gain (at 50% duty cycle)
Barrel DIRC				
<i>at end of radiator</i>	60	5.6	28	
at readout plane	1.7	0.2	1	5
Endcap DIRC				
<i>at rim of radiator</i>	19	2	10	
focussing	7.5	0.8	4	20

- **Endcap DIRC** with much higher photon rate than Barrel DIRC
→ **wavelength band filter to reduce photon rate**



Rate Capability

Rate Capability of various MCP-PMTs



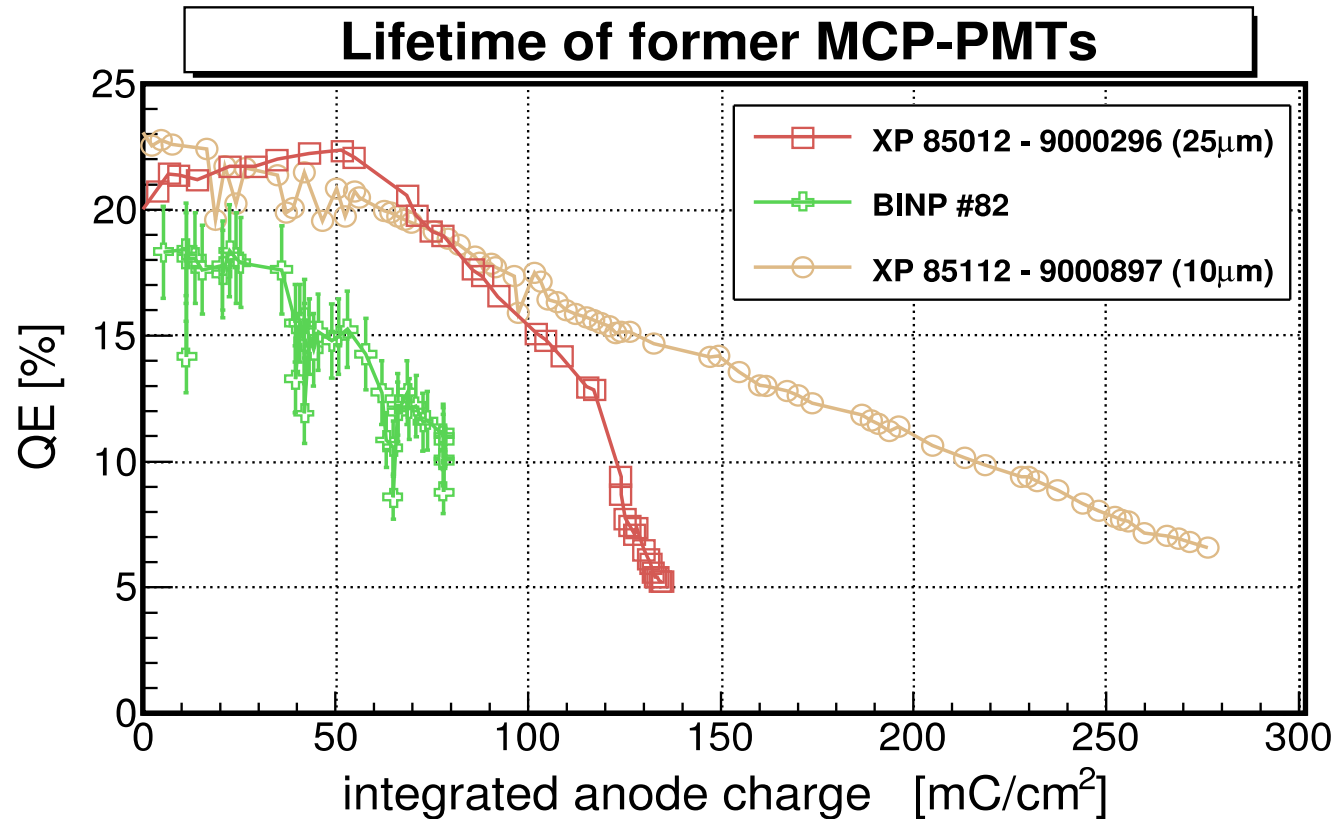
- most MCP-PMTs show **stable operation to ~200-300 kHz/cm² single photons** (at gain 10⁶)
- many recent MCP-PMT models stable up to >1 MHz/cm²



Lifetime of former MCP-PMTs

Status ~4 years ago

- BINP with Al_2O_3 film at MCP entrance to stop feedback ions
- PHOTONIS with improved vacuum and electron scrubbing of surfaces



- Quantum efficiency reduced by 50% or more at $<200 \text{ mC/cm}^2$
- By far not sufficient for PANDA



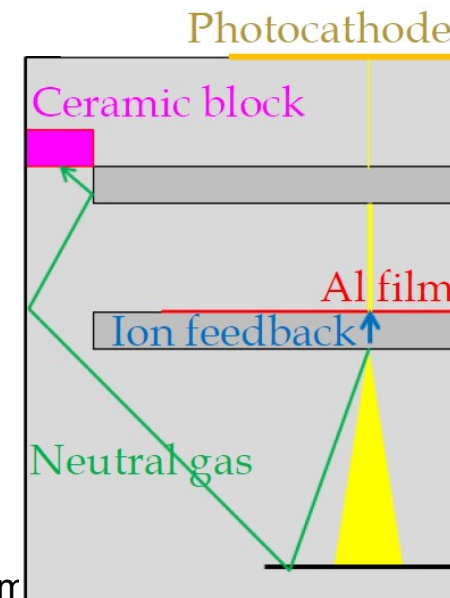
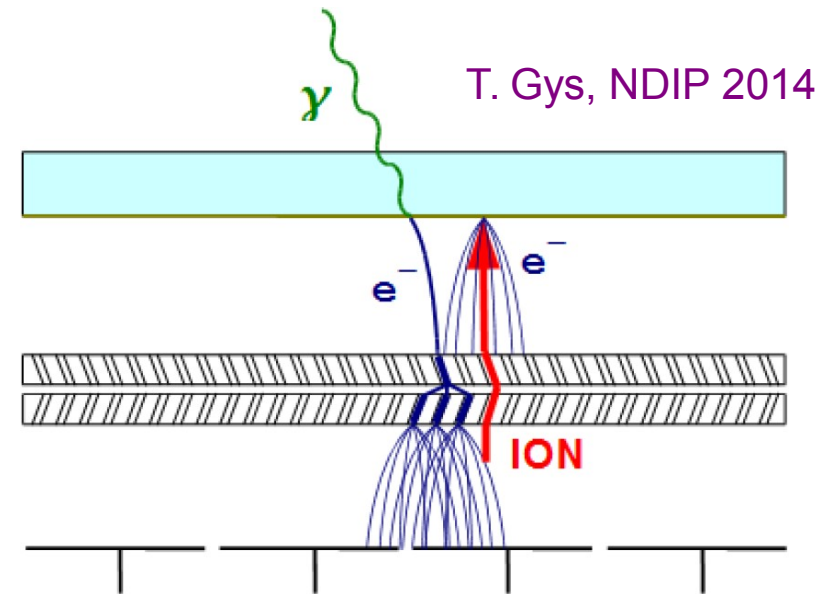
Possible Cause of MCP Aging

● Ion feedback

- Amplification process causes
 - Ionization of residual gas atoms
 - Desorption of atoms from MCP material (especially H and Pb)
 - Damaging of MCP surfaces → gain may change
- Ions accelerated towards photo cathode
 - Production of secondary pulse
 - Ions may react with PC
 - PC gets damaged and work function may gradually change
 - Degradation of Quantum efficiency (QE)

● Neutral molecules from residual gas

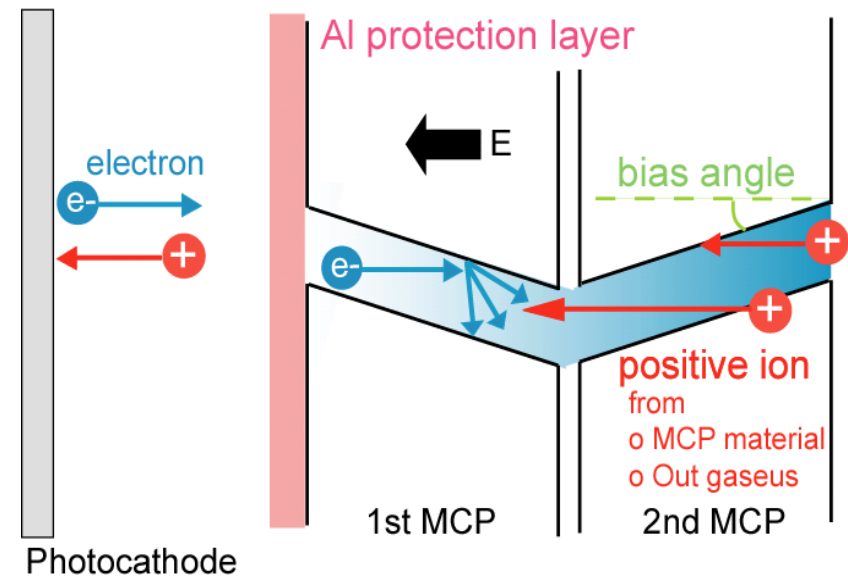
- Passing between MCPs and walls
- CO_2 , O_2 and H_2O react with PC



First Approaches to Reduce Aging

● Stop feedback ions by thin Al_2O_3 film (5-10 nm)

- In front of first MCP layer (older BINP and first Hamamatsu tubes)
 - disadvantage: another reduction of collection efficiency (CE) by about 1/3
- Later between MCP layers (second generation Hamamatsu tubes)
 - no CE reduction but higher HV needed



● Improve vacuum quality

● Improved cleaning of MCP surfaces

- Electron scrubbing (older PHOTONIS and latest BINP tubes)

● Prevent neutral molecules in anode region from reaching the PC

- Anode region is hermetically sealed from PC region (2nd gen. Hamamatsu)
 - [NIM A629 (2011) 111]



Production of more Robust PC

MCP-PMTs developed at BINP for FARICH

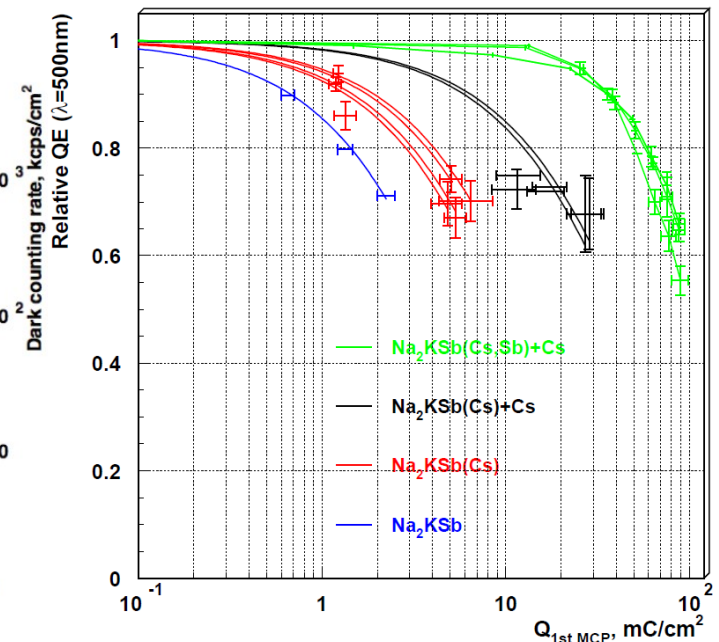
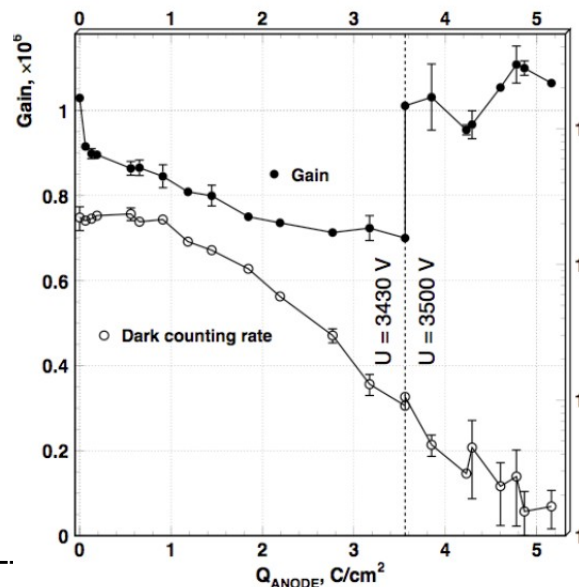
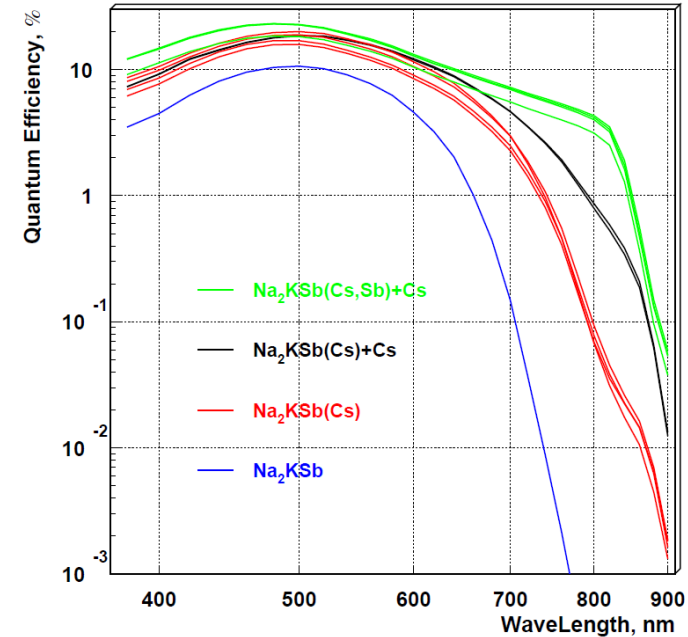
- without protection layer
- with heavy electron scrubbing

New photo cathode [JINST 6 C12026 (2011)]

- Na_2KSb : DCR < 0.5 kHz/cm²
- $\text{Na}_2\text{KSb}(\text{Cs})$: DCR = 0.5 kHz/cm²
- $\text{Na}_2\text{KSb}(\text{Cs}) + \text{Cs}$: DCR = 5 kHz/cm²
- $\text{Na}_2\text{KSb}(\text{Cs}) + \text{Cs}_3\text{Sb}$: DCR = 50-100 kHz/cm²

Gain recoverable

Exponential reduction of dark count rate (DCR)





Atomic Layer Deposition (ALD)

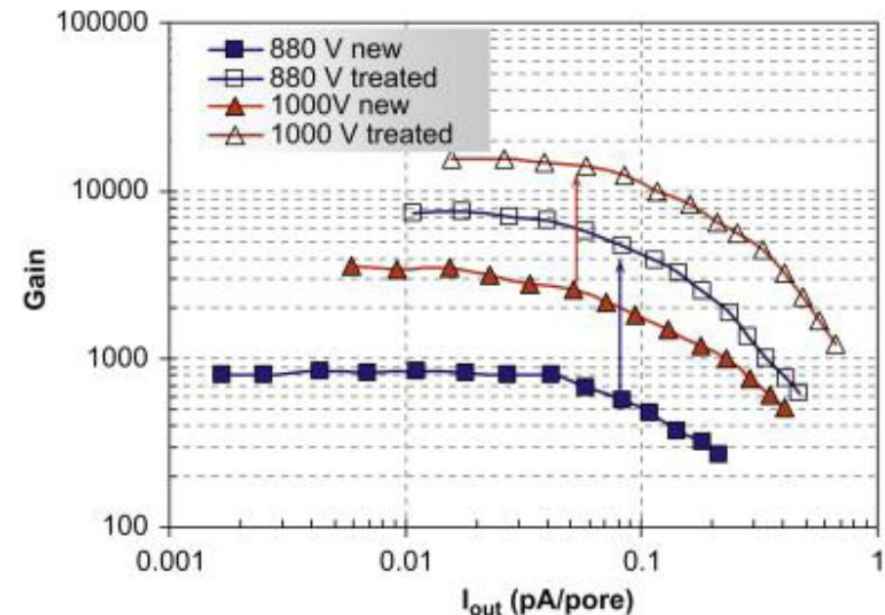
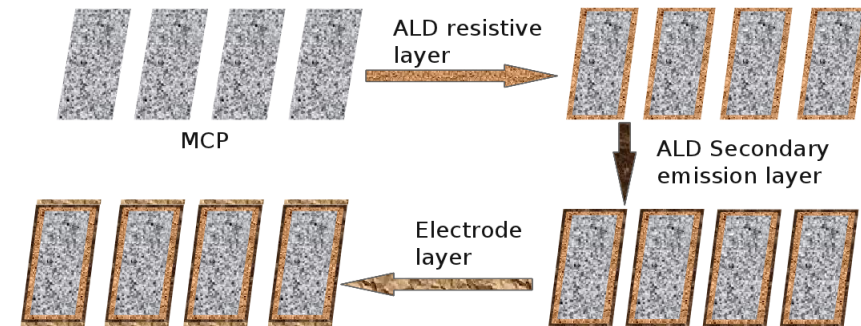
- Deposition of ultra-thin atomic layer (MgO, Al₂O₃) on MCP substrate

- Arradance Inc. → LAPPD, Photonis, ...
- MCP pores are coated in three steps
 - resistive layer
 - secondary electron emission (SEE) layer
 - electrode layer
- Optimisation of MCP resistance and SEE
 - for each film independently
 - higher gain at given HV

- Possibility to use MCP substrates other than lead glass

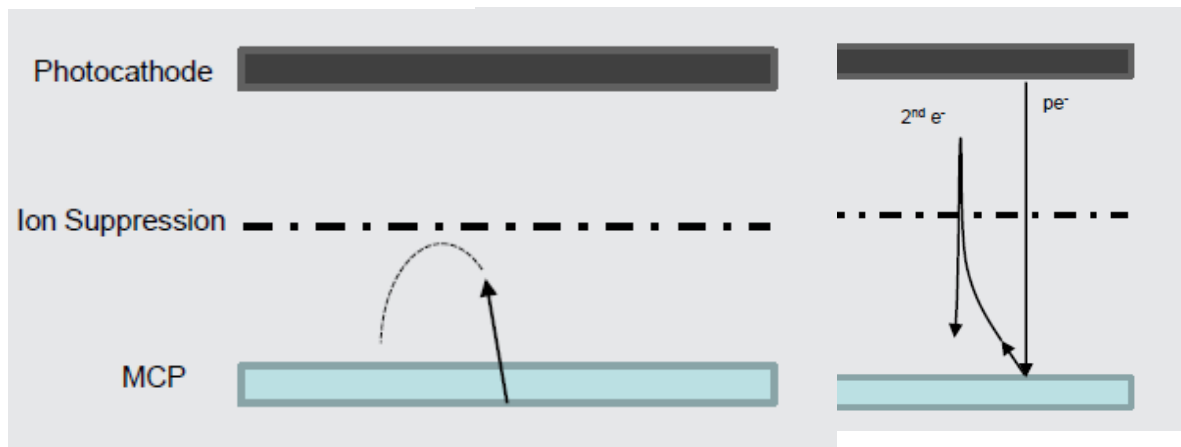
- e.g., borosilicate glass
 - higher bake-out temperature possible
 - fewer outgassing during MCP operation

[NIM A639 (2011) 148]



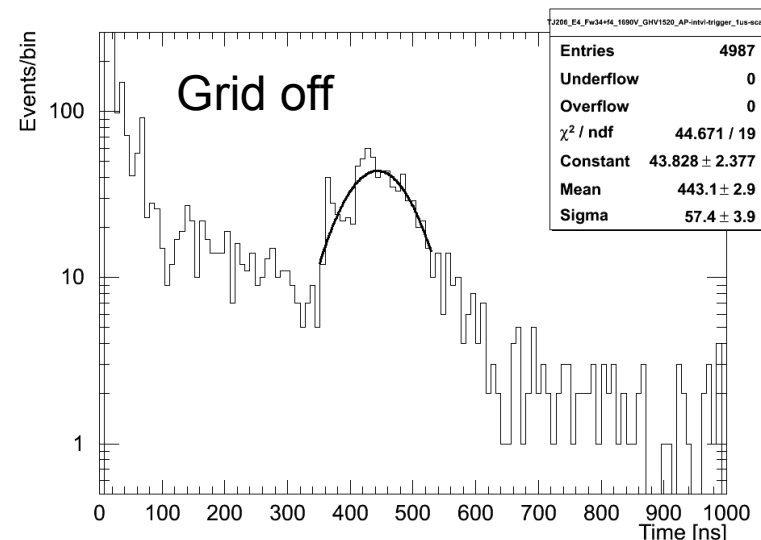


New Development with Grid

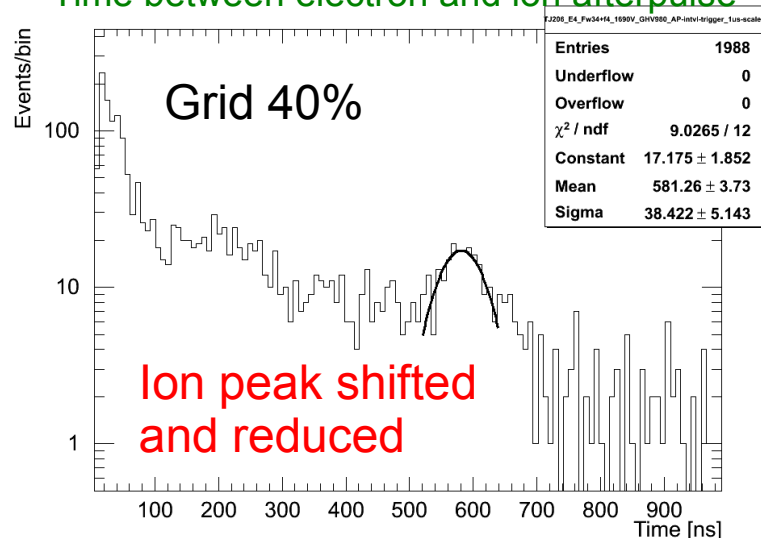


- Grid between MCP and PC to prevent ions from reaching and damaging PC
 - parallel development at PHOTONIS
 - For full ion suppression grid bias needs to be higher than bias at MCP-out
- Additional effect: Tail in TTS distribution can be suppressed
 - Tail is shifted and separated from main peak due to delay of backscattered electrons

A. Brandt, Picosecond Timing Workshop 2014



Time between electron and ion afterpulse

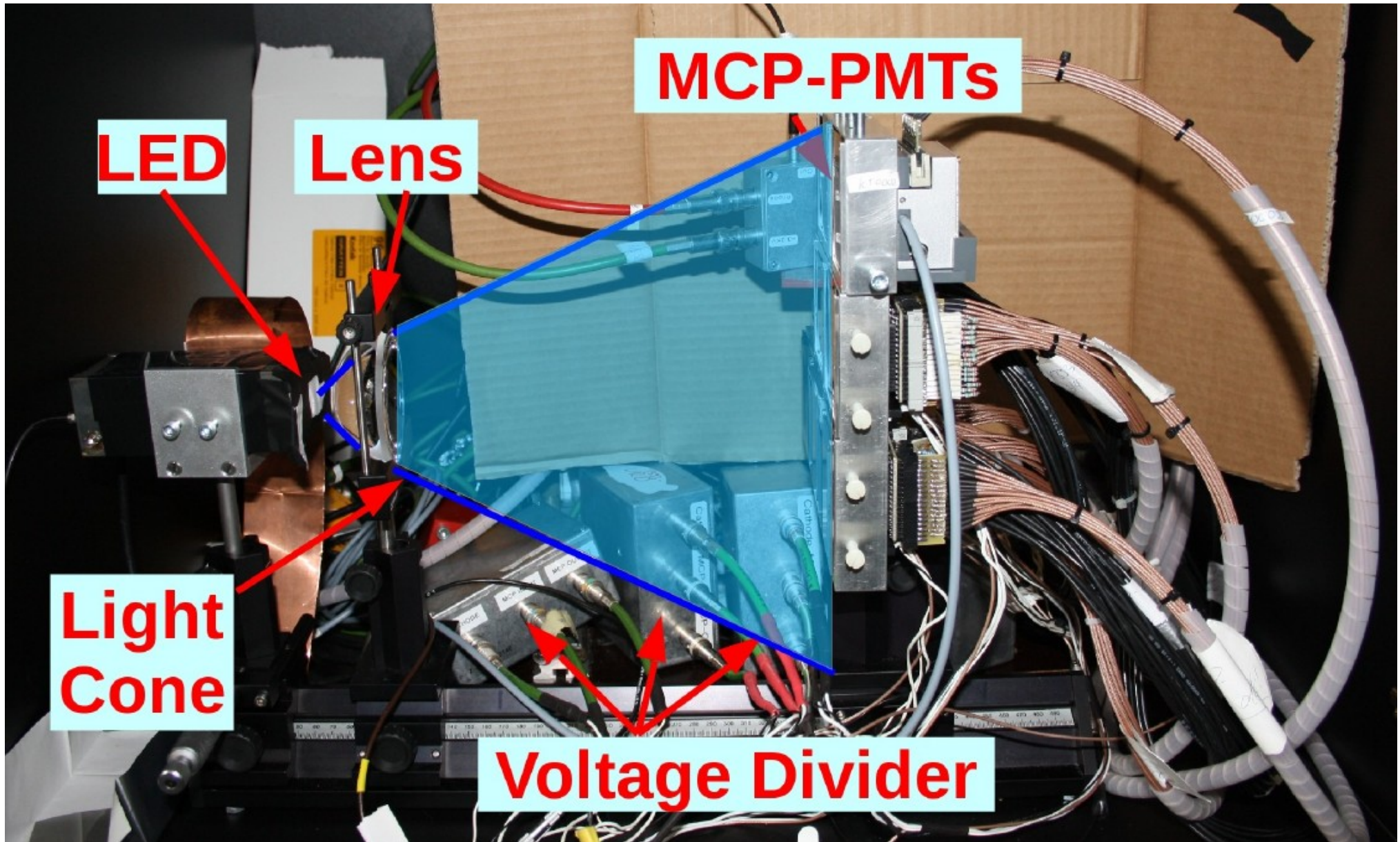


Simultaneous Aging of MCP-PMTs

- **Problem in 2011:** The few aging tests existing were done in rather different environments → results are difficult to compare
- **Goal:** measure aging behavior for all available lifetime-enhanced MCP-PMTs in same environment
- **Simultaneous illumination** with common light source → same rate
- MCP-PMTs included in aging tests of last 4 years:
 - 2x BINP
 - improved vacuum and scrubbed surfaces + new photo cathode (both finished)
 - 4x Hamamatsu R10754X (1x1 inch²)
 - L4 and M16: protection layer (film) between 1st and 2nd MCP (both finished)
 - 2x M16M: ALD technique applied (+ film between MCPs) (started end 2013)
 - 3x PHOTONIS XP85112 (2x2 inch²)
 - 1-layer ALD surfaces (2x) and 2-layer ALD surfaces (1x, started Jan. 2014)
 - surface half covered during illumination (except 2-layer ALD tube)
 - 4x Hamamatsu R13266 (2x2 inch²) with ALD and film (starting soon)



Illumination Setup





Measurement of MCP Lifetime

Continuous illumination

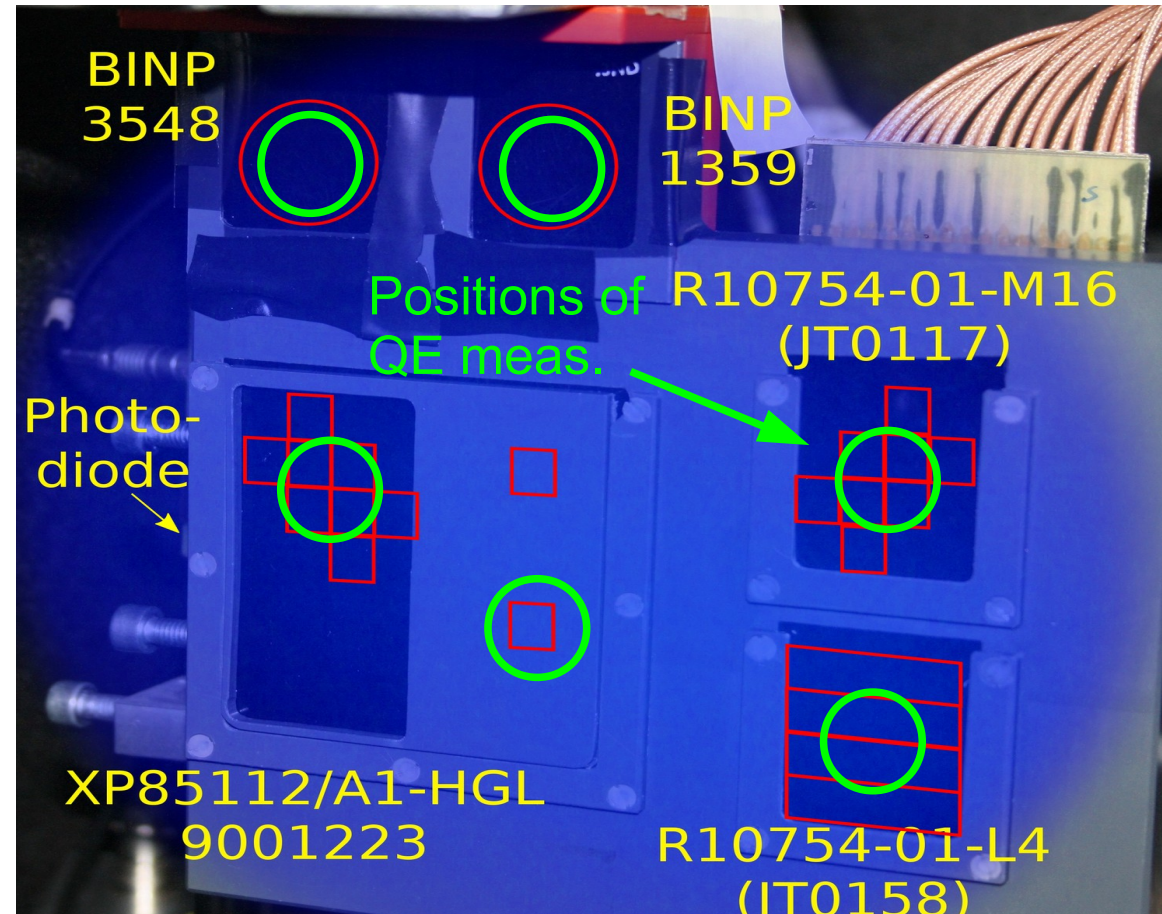
- 460 nm LED at 0.25 to 1 MHz rate attenuated to single photon level
→ 3 to 20 mC/cm²/day

Permanent monitoring


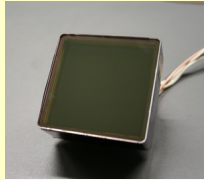

- MCP pulse heights and LED light intensity

Q.E. measurements

- 250–700 nm wavelength band with monochromator $\Delta\lambda = 1$ nm
- Every 2-3 weeks (at beginning days): wavelength scan
- Every 3-4 months (at beginning weeks): complete surface scan



Lifetime-Investigated MCP-PMTs

	BINP		PHOTONIS			Hamamatsu	
			XP85012	XP85112	XP85112	R10754X-01-M16	R10754X-07-M16M
pore size (μm)	6	7	25	10	10	10	10
number of pixels	1	1	8x8	8x8	8x8	4x4	4x4
active area (mm^2)	$9^2 \pi$	$9^2 \pi$	53x53	53x53	53x53	22x22	22x22
total area (mm^2)	$15.5^2 \pi$	$15.5^2 \pi$	59x59	59x59	59x59	27.5x27.5	27.5x27.5
geom. efficiency (%)	36	36	81	81	81	61	61
photo cathode	multi-alkali		bi-alkali			multi-alkali	
peak Q.E.	21% @ 495 nm	21% @ 495 nm	20% @ 380 nm	23% @ 380 nm	22% @ 380 nm	21% @ 375 nm	22% @ 415 nm
comments		better vacuum, new cathode	better vacuum, polished surfaces	better vacuum, polished surfaces	better vacuum, ALD surfaces	film between MCPs	further improved lifetime (ALD)
# of tubes measured	1	2	1	1	3	1 (+1 L4)	2
							

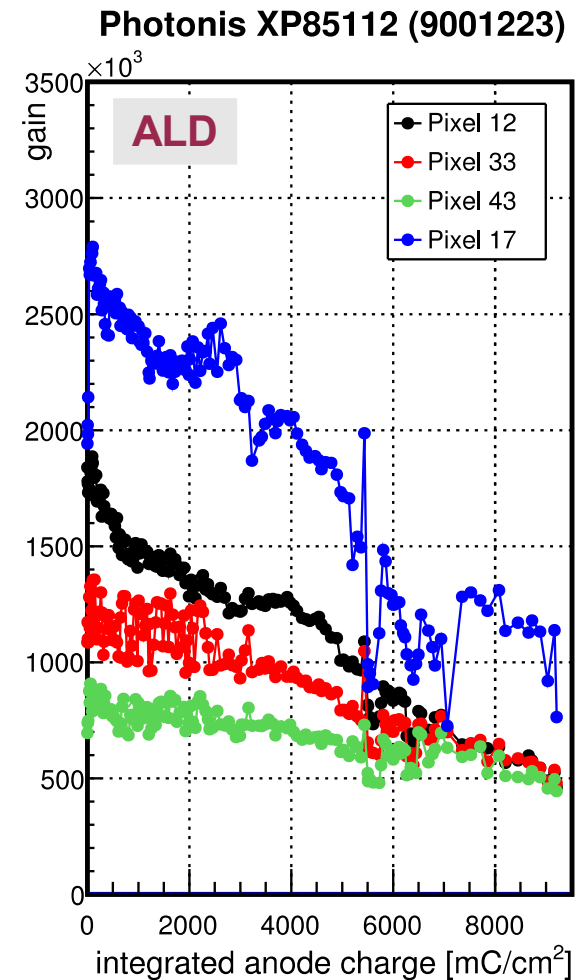
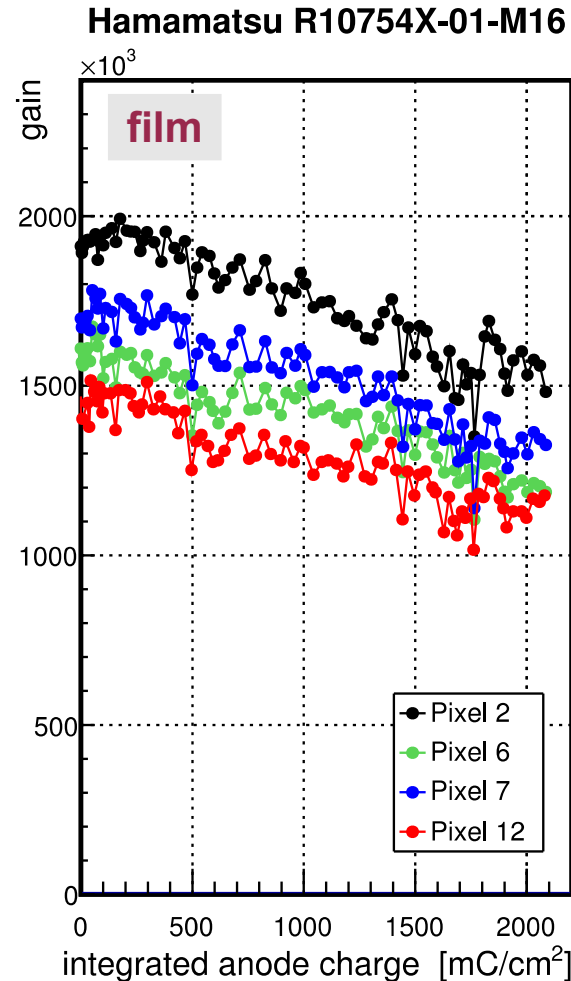
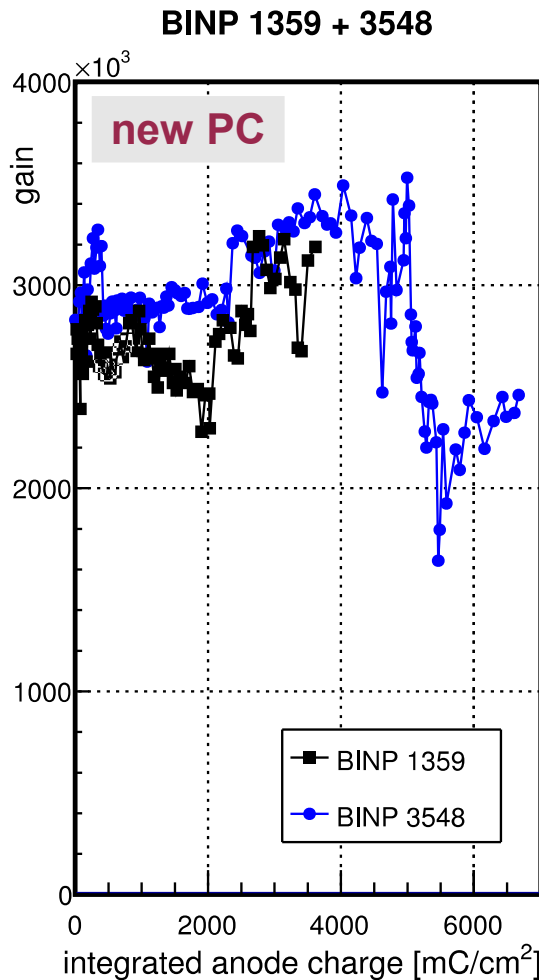
- Tubes first measured with no significant lifetime improvements
- Lifetime improved tubes measurement started ~4 years ago
- Hamamatsu 1 inch ALD tubes measurement started ~2 year ago
- Hamamatsu 2 inch ALD tubes will be starting soon



Illumination Overview

	Sensor ID	Integral charge (Nov. 9, 2015) [mC/cm ²]	QE start [%]	QE latest [%]	QE latest / QE start [%]	Comments
Photonis XP85112	9001223	9234	22.11	5.29	24%	Start: 23 Aug. 11 Stop: 22 Sep. 15
	9001332	9264	22.62	22.71	100%	Start: 12 Dec. 12 ongoing
	9001393	5441	19.05	19.89	104%	Start: 23 Jan. 14 ongoing
Hamamatsu R10754X	JT0117 (M16)	2086	19.97	9.32	47%	Start: 23 Aug. 11 Stop: 24 Jul. 12
	KT0001 (M16M)	10035	21.71	15.33	71%	Start: 20 Aug. 13 ongoing
	KT0002 (M16M)	5868	21.14	14.8	70%	Start: 21 Oct. 13 ongoing
BINP	1359	3616	12.27	9.06	74%	Start: 21 Oct. 11 Stop: 06 May 13
	3548	6698	12.23	4.58	37%	Start: 21 Oct. 11 Stop: 08 Jul. 15

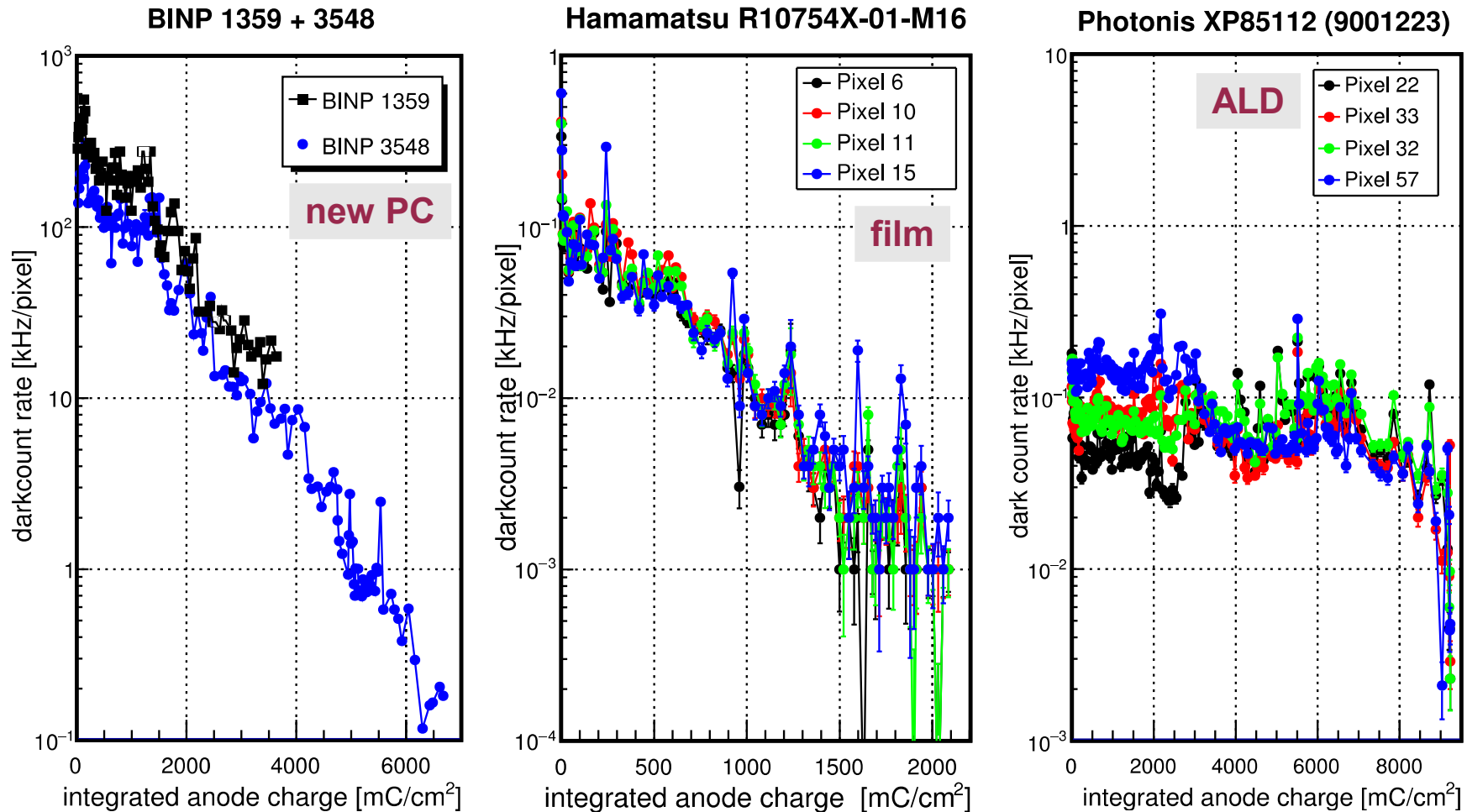
Gain vs. Integrated Anode Charge



- Only moderate gain changes
- This was quite different in the former MCP-PMTs !

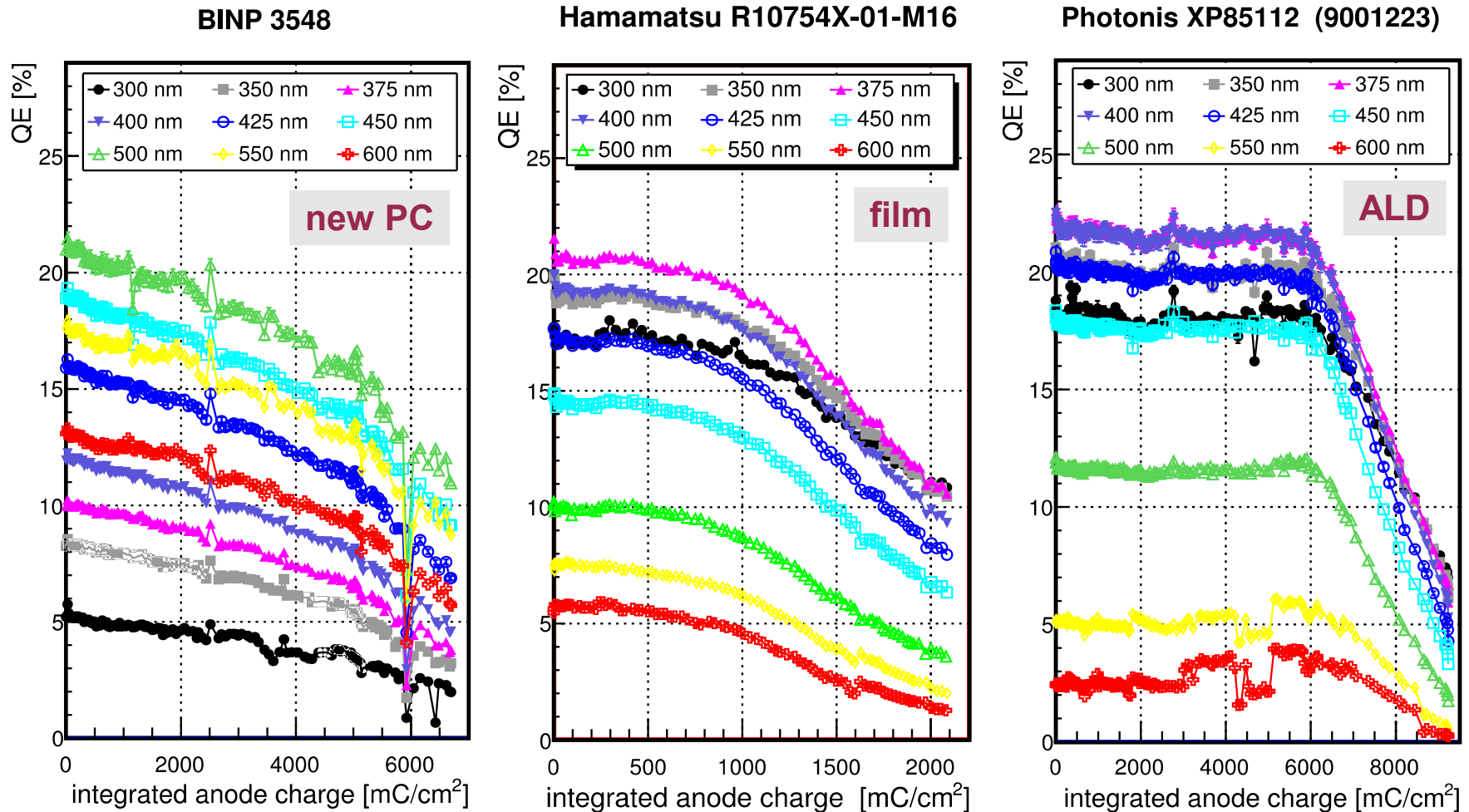


Darkcount vs. Anode Charge



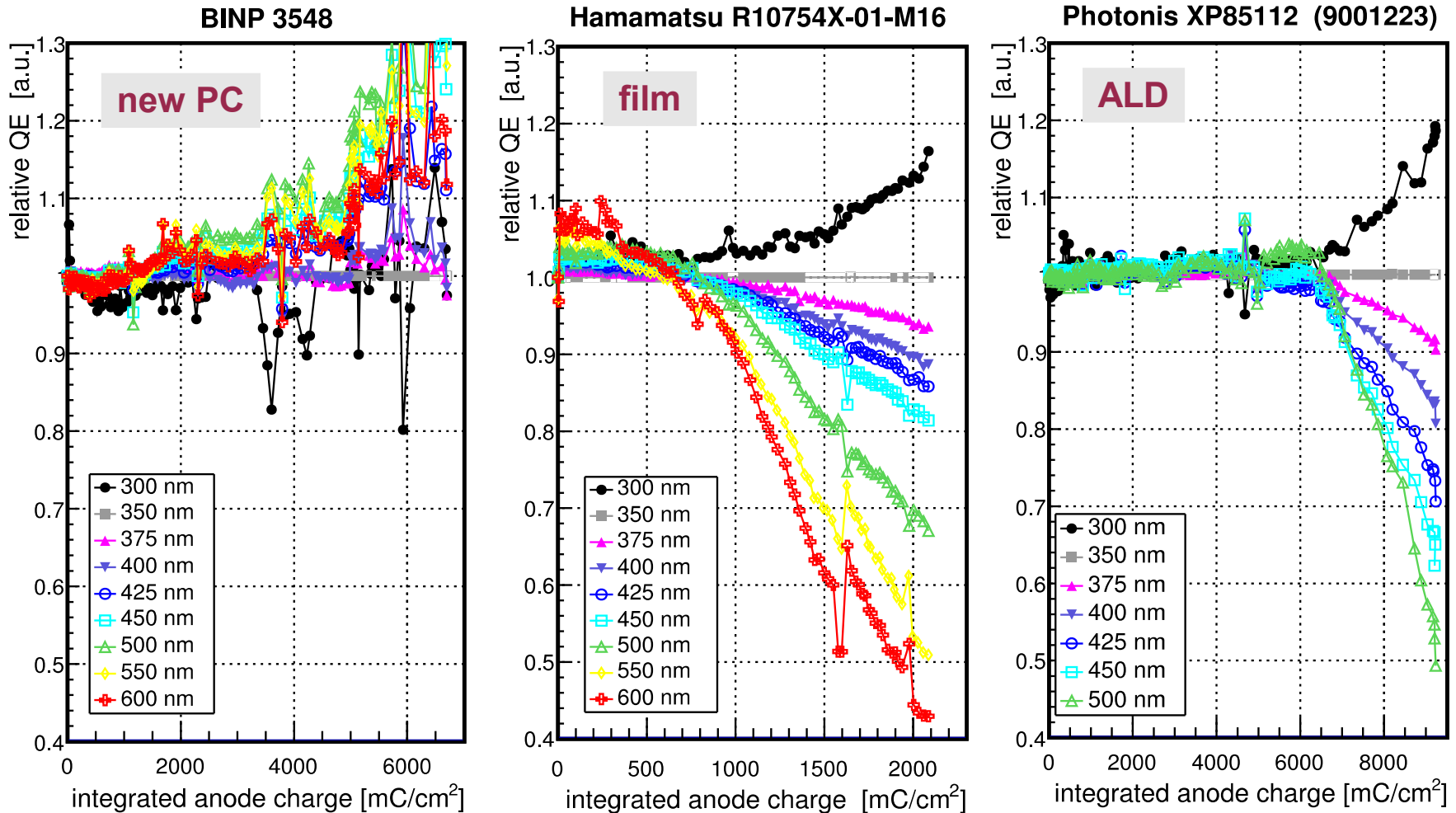
- Darkcount rate of PHOTONIS XP85112 (ALD) almost constant
- Big exponential reduction in BINP and Hamamatsu R10754X

Q.E.(λ) vs. Integral Anode Charge



● BINP new PC: continuous Q.E. degradation
● Hamamatsu film: Q.E. drops significantly above ~1 C/cm²
● PHOTONIS ALD: Q.E. degradation after 6 C/cm²

Relative Q.E.(λ) vs. Anode Charge



● BINP new PC: signature not easy to interpret
● Hamamatsu film and Photonis ALD: **once Q.E. starts degrading red light drops faster than blue (→ work function changes)**



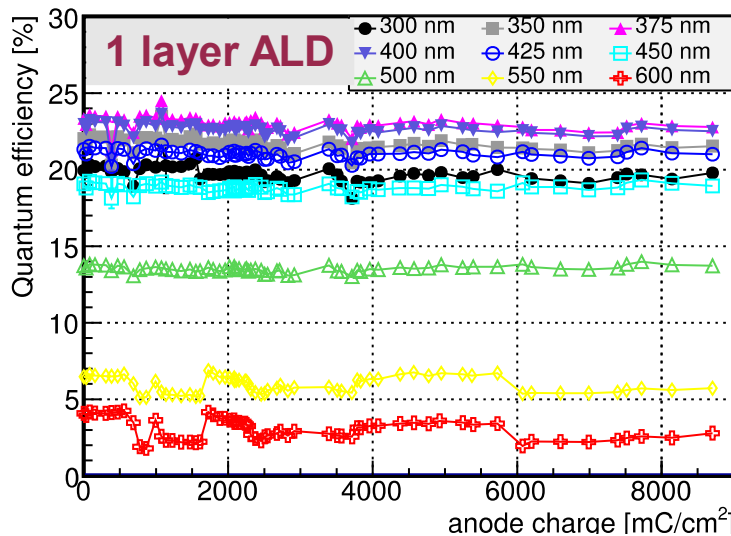
Q.E.(λ) vs. Anode Charge

PHOTONIS
2 inch

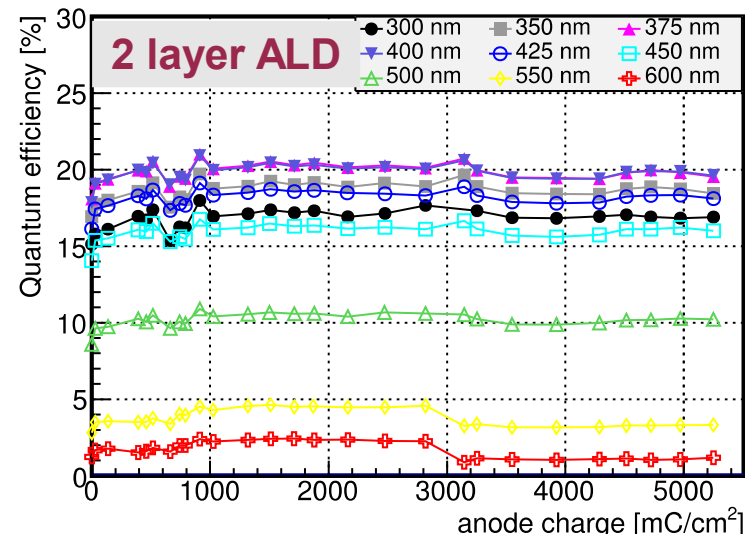
Status at
Oct. 19, 2015

Hamamatsu
1 inch

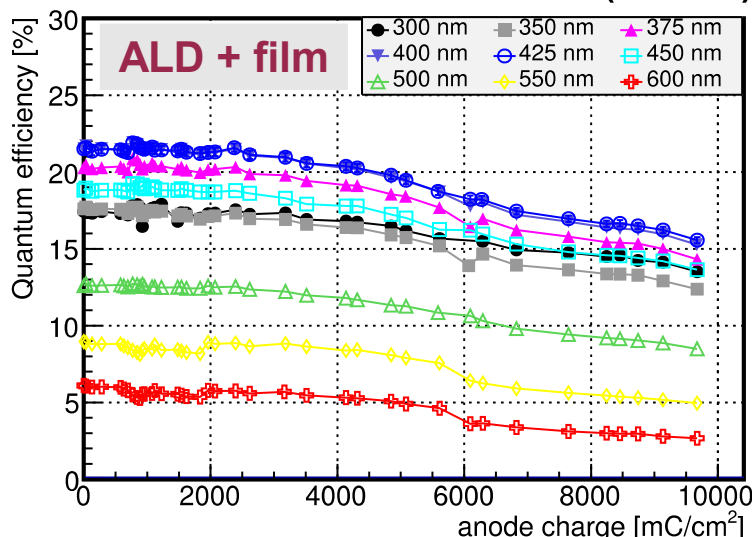
Photonis XP85112 (9001332)



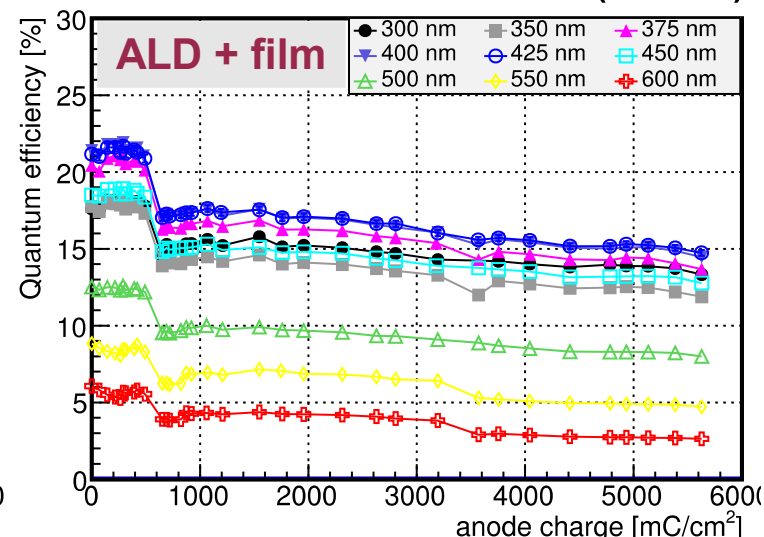
Photonis XP85112 (9001393)



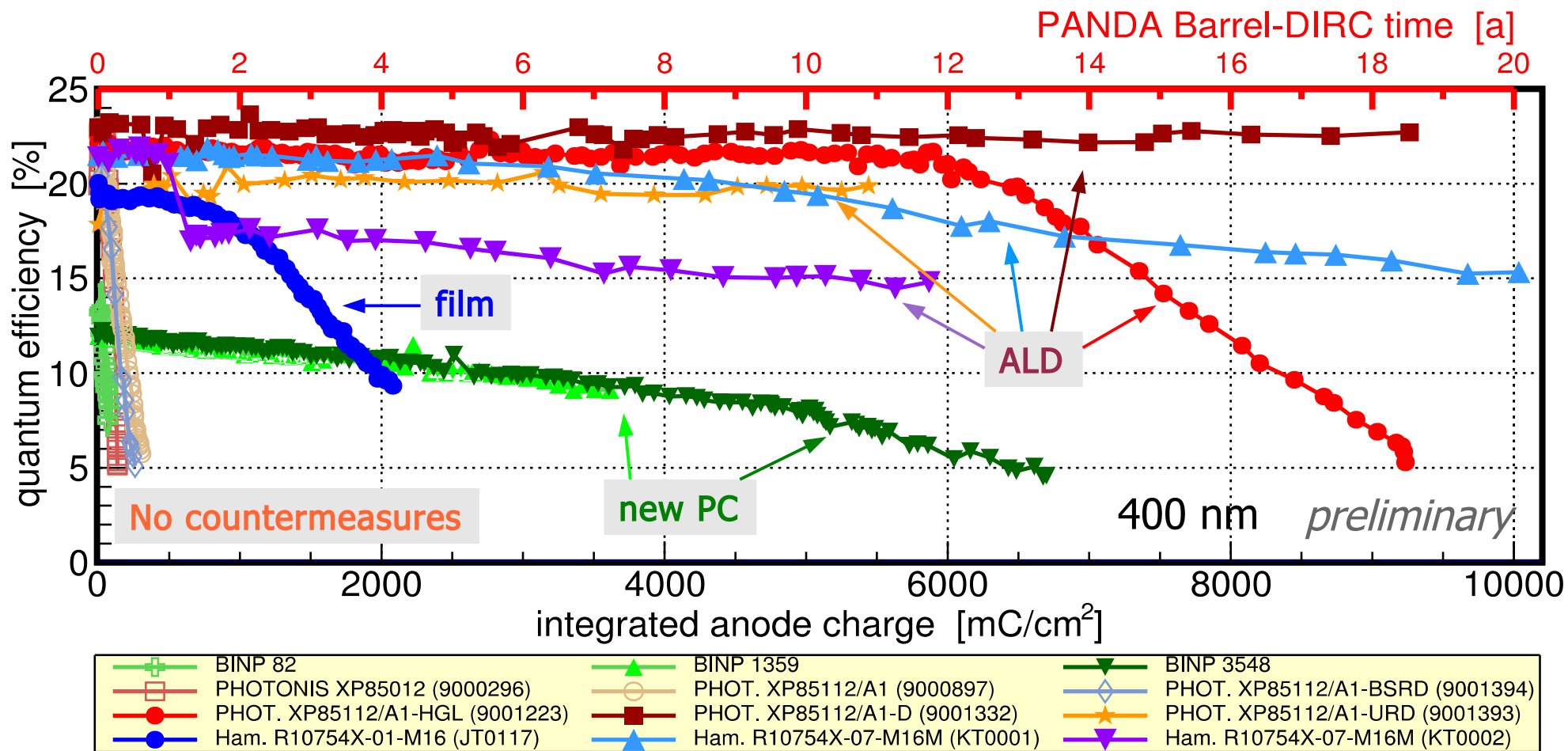
Hamamatsu R10754X-07-M16M (KT0001)



Hamamatsu R10754X-07-M16M (KT0002)



Lifetime of MCP-PMTs (Nov. 2015)

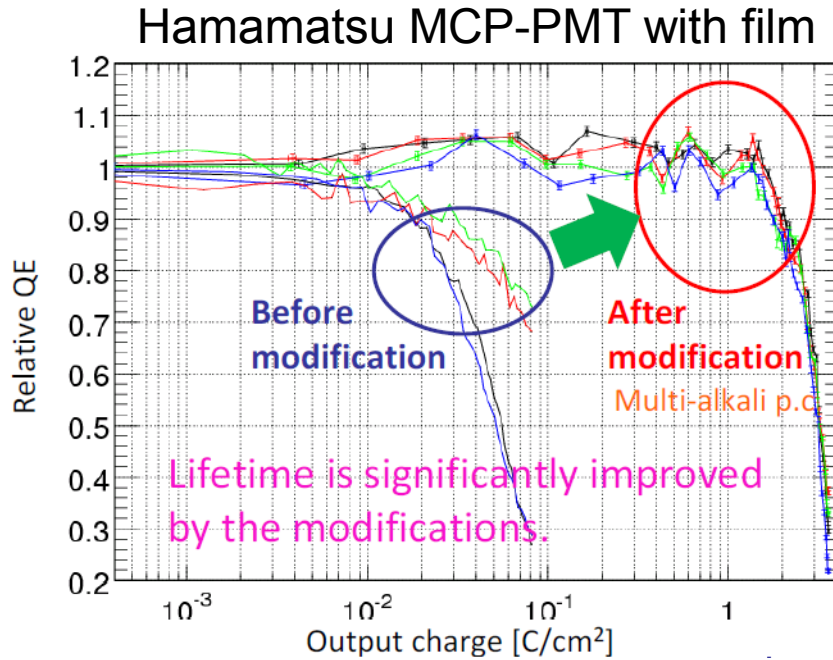


- Hamamatsu film MCP-PMT: Q.E. drops beyond $1 \text{ C}/\text{cm}^2$
- Photonis 9001332: no Q.E degrading observed yet up to $>9 \text{ C}/\text{cm}^2$
- MCP-PMTs with ALD layers: **very good performance to $>5 \text{ C}/\text{cm}^2$**

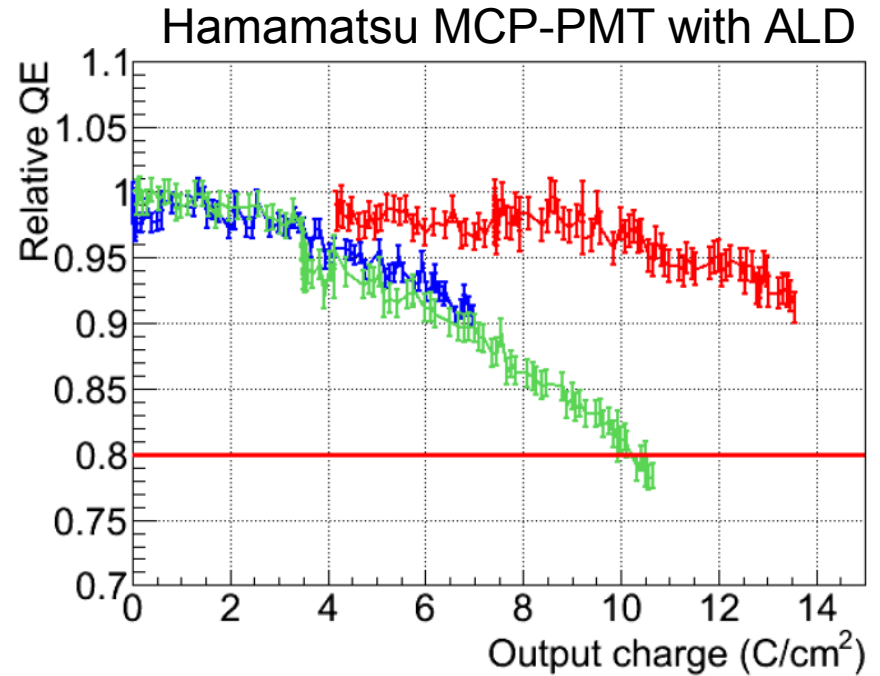


Lifetime Results at Belle II

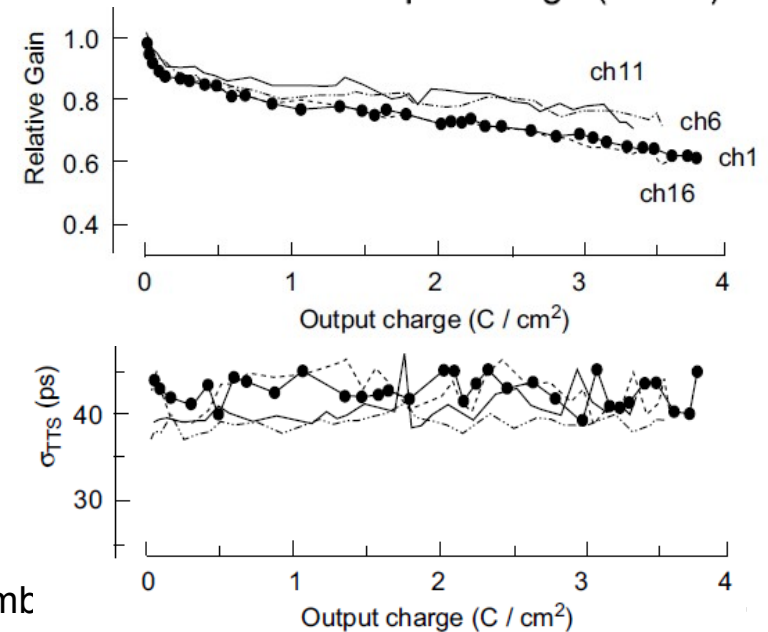
NIM A629 (2011) 111



K. Matsuoka, RICH2013



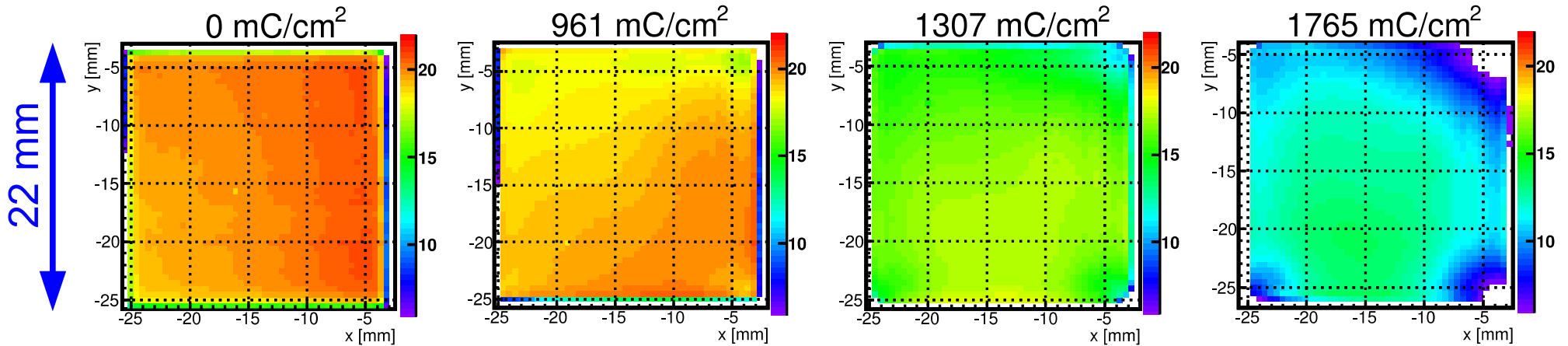
- Hamamatsu 1 inch MCP-PMTs with film good to $\sim 2 \text{ C/cm}^2$
- Big improvement with ALD technique, but first results were not reproduced
- Moderate gain drop
- No changes in time resolution



Q.E. Scans (Hamamatsu & BINP)

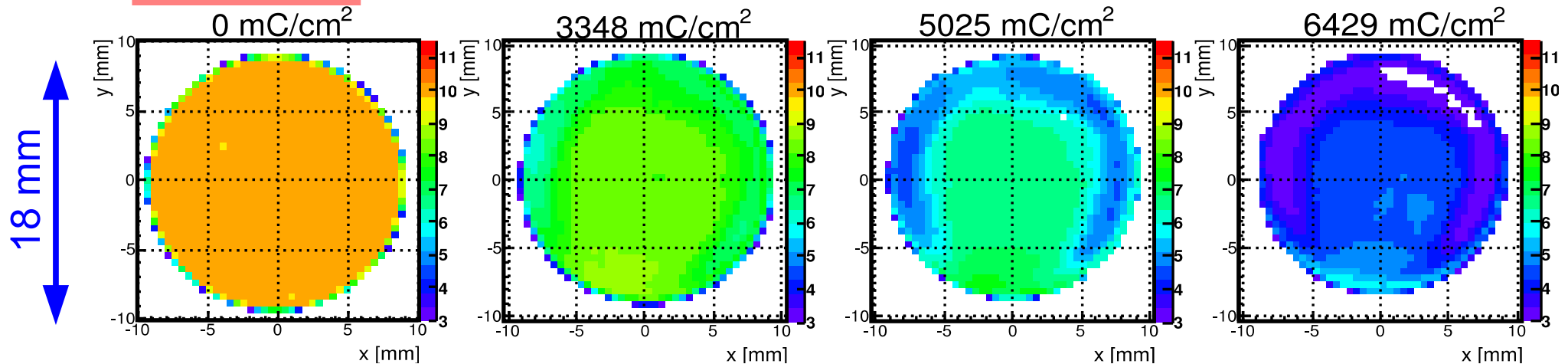
Q.E. measured at 372 nm

film Hamamatsu R10754X-M16



new PC BINP 3548

QE degradation evolves from rims and corners





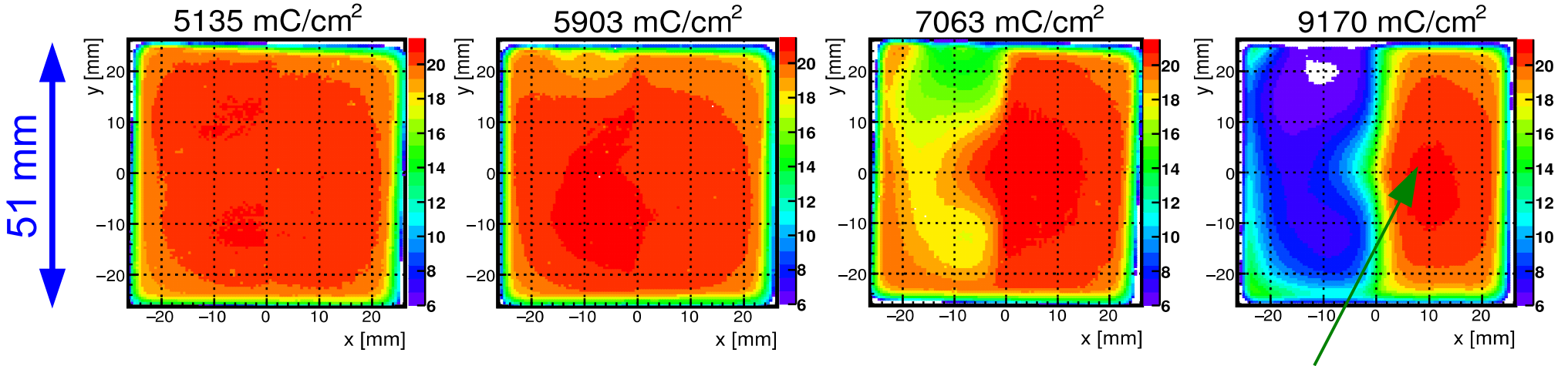
Q.E. Scans (PHOTONIS ALD)

ALD

PHOTONIS XP85112 (9001223)

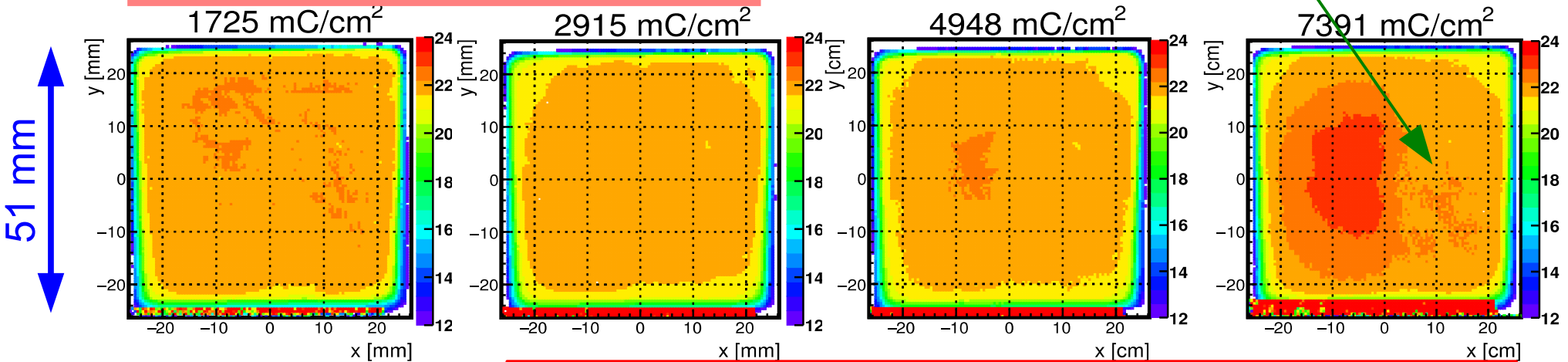
Q.E. measured at 372 nm

status in mid August 2015



ALD

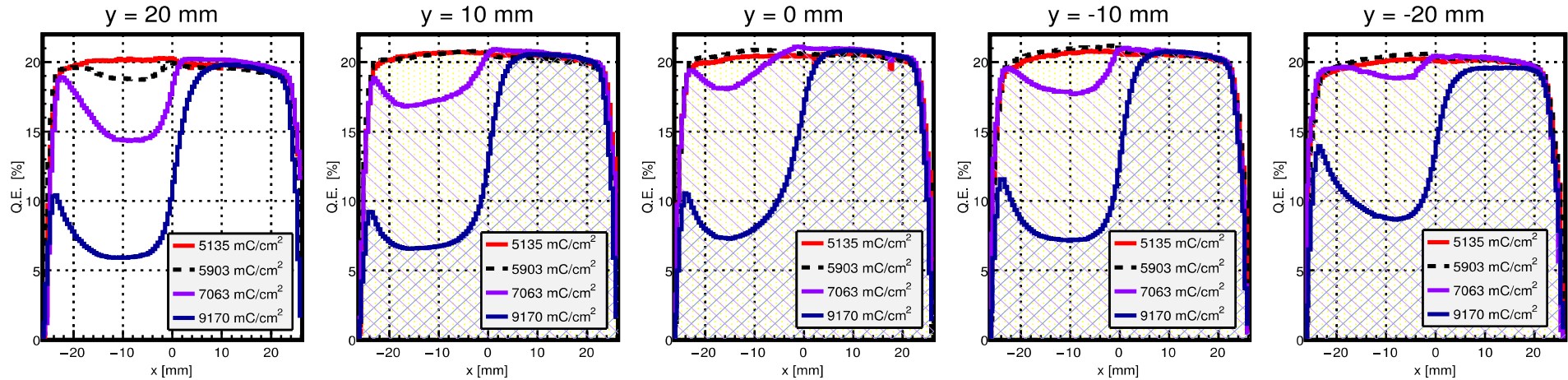
PHOTONIS XP85112 (9001332)



Q.E. Scan Projection (PHOTONIS ALD)

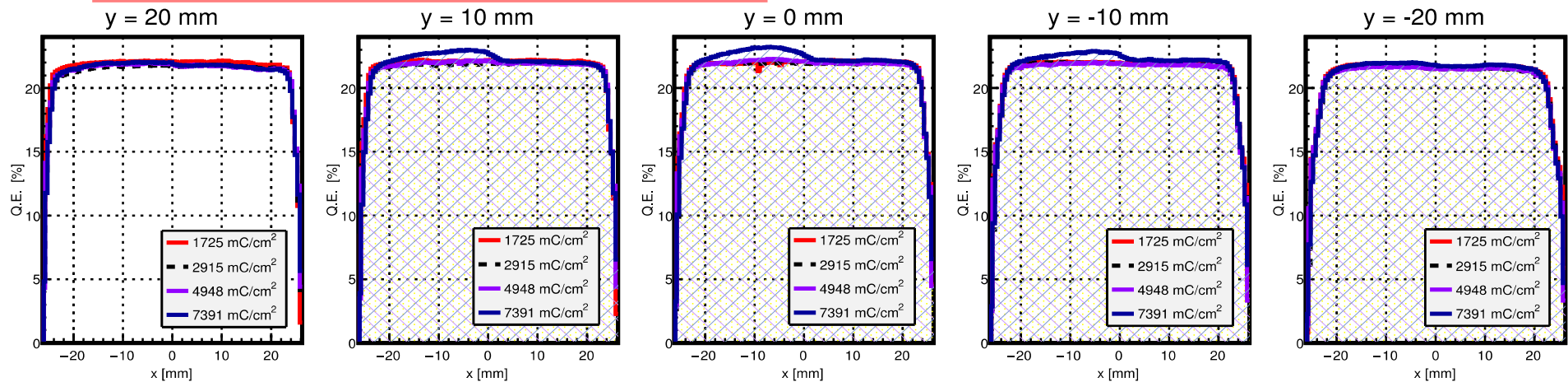
ALD

PHOTONIS XP85112 (9001223)



ALD

PHOTONIS XP85112 (9001332)



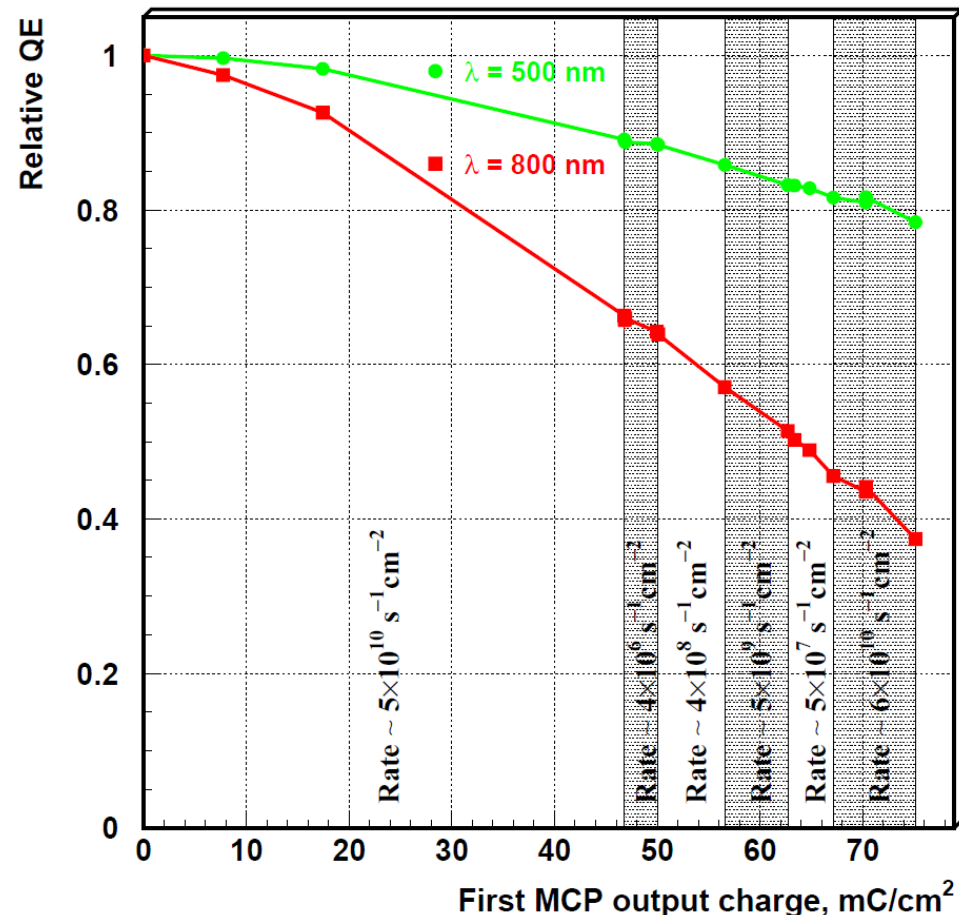
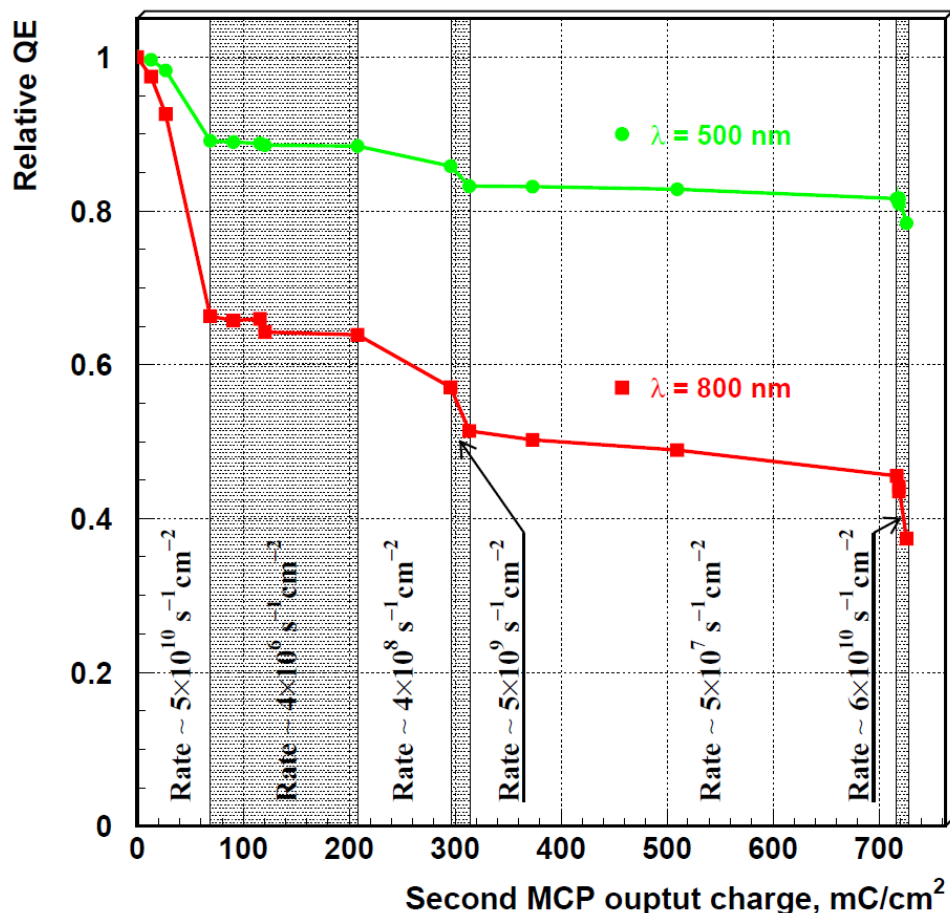


Summary and Outlook

- Aging symptoms
 - PC work function changes (darkcount, wavelength dependence)
 - PC damage starts from rims and corners
 - Ion feedback dominant reason for aging
- **Spectacular lifetime increase of latest MCP-PMTs** due to recent design improvements
 - application of ALD technique (x50 lifetime improvement)
 - huge step forward !
- Equipping the PANDA DIRCs and other high rate detectors with MCP-PMTs appears feasible

Accelerate Aging Measurements

M.Yu. Barnyakov and A.V. Mironov, 2011 JINST 6 C12026

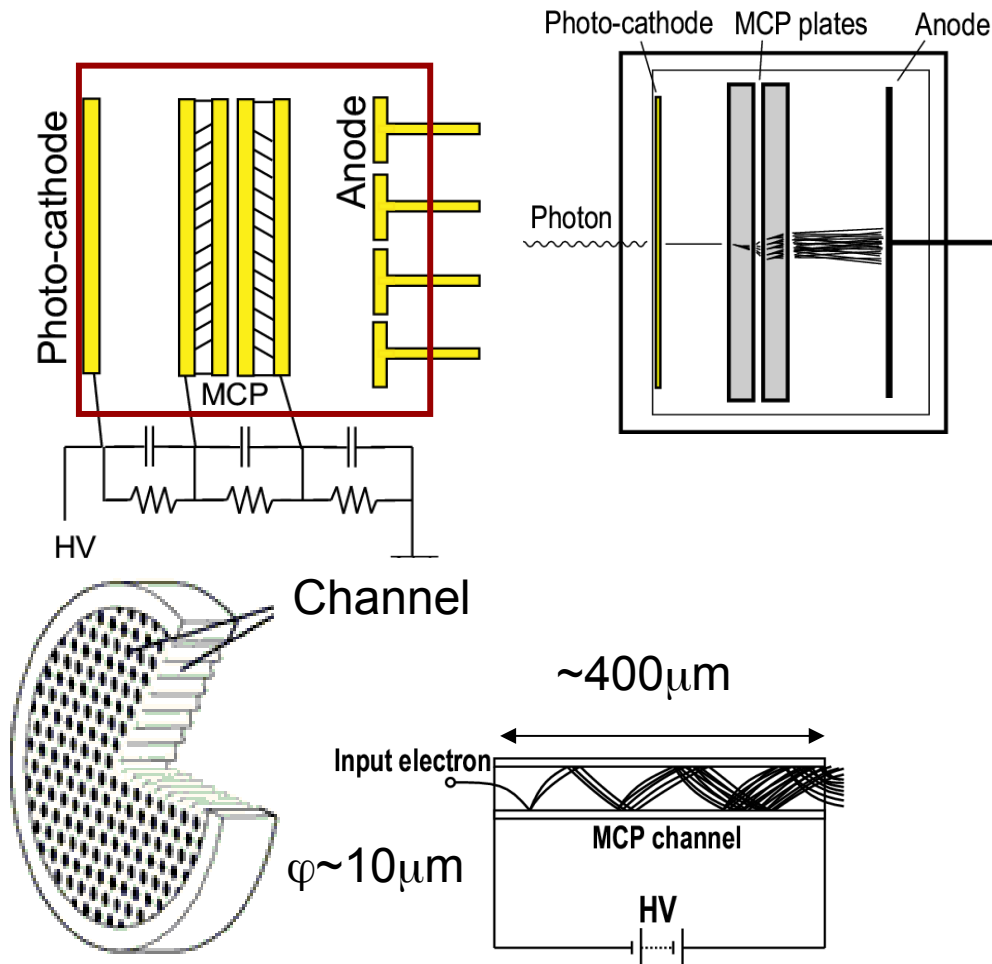


- At 2nd MCP output QE degradation rate depends on count rate
- At 1st MCP no correlation between QE degradation and count rate



Microchannel-Plate PMT

electron multiplication in glass capillaries ($\varnothing \approx 10\text{-}25 \mu\text{m}$)



- usable in high magnetic fields
- high gain:
 - $>10^6$ with 2 MCP stages
 - single photon sensitivity
- very fast time response:
 - signal rise time = 0.3 – 1.0 ns
 - TTS < 50 ps
- low dark count rate
- quantum efficiency comparable to that of standard vacuum PMTs
- multi-anode PMTs available
- caveats:
 - lifetime (QE drops)
 - price